

Notice of References Cited

Application/Control No.

10/581,322

Applicant(s)/Patent Under
Reexamination
FUKUI ET AL.

Examiner

SUN JAE Y. LOEWE

Art Unit

1626

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,875,780	04-2005	Auerbach et al.	514/345
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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